

1.0 SCOPE

This specification covers the detail requirements for a dual precision JFET input operational amplifier.

It is highly recommended that this data sheet be used as a baseline for new military or aerospace spec control drawings.

1.2 Part Number. The complete part numbers per Table I of this specification follow:

<u>Device</u>	<u>Part Number</u>	<u>Package</u>
A	OP-215AJ/883	J
B	OP-215BJ/883	J
C	OP-215CJ/883	J
A	OP-215AZ/883	Z
B	OP-215BZ/883	Z
C	OP-215CZ/883	Z
B	OP-215BRC/883	RC

1.2.3 Case Outline.

<u>Letter</u>	<u>Case Outline (Lead finish per MIL-M-38510)</u>
J	8-lead metal can (TO-99)
Z	8-lead ceramic dual-in-line package (CERDIP)
RC	20-contact hermetic leadless chip carrier (LCC)

1.3 Absolute Maximum Ratings. ($T_A = 25^\circ\text{C}$, unless otherwise noted)

Supply Voltage OP-215A, OP-215B	$\pm 22\text{V}$
OP-215C.....	$\pm 18\text{V}$
Power Dissipation	500mW
Differential Input Voltage OP-215A, OP-215B	$\pm 40\text{V}$
OP-215C.....	$\pm 30\text{V}$
Input Voltage (Note 1) OP-215A, OP-215B.....	$\pm 20\text{V}$
OP-215C.....	$\pm 16\text{V}$
Output Short-Circuit Duration	Indefinite
Operating Temperature Range	-55°C to +125°C
Storage Temperature Range	-65°C to +150°C
Lead Temperature (Soldering, 60 sec)	+300°C
Maximum Junction Temperature (T_J).....	+150°C

NOTES:

1. Unless otherwise specified, the absolute maximum negative input voltage is equal to the negative power supply voltages.

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1.5 Thermal Characteristics:

Thermal Resistance, TO-99 (J) package:

Junction-to-Case (Θ_{JC}) = 45 °C/W MAX

Junction-to-Ambient (Θ_{JA}) = 150 °C/W MAX

Thermal Resistance, CERDIP (Z) package:

Junction-to-Case (Θ_{JC}) = 26 °C/W MAX

Junction-to Ambient (Θ_{JA}) = 119 °C/W MAX

Thermal Resistance, LCC (RC) package:

Junction-to-Case (Θ_{JC}) = 35 °C/W MAX

Junction-to Ambient (Θ_{JA}) = 110 °C/W MAX

TABLE 1

$V_S = \pm 15V$; $R_S = 50\Omega$; $V_{CM} = 0V$; $T_A = 25^\circ C$ unless otherwise specified.

Characteristics	Symbol	Special Conditions	OP-215/883				Units
			Min	Max	Min	Max	
Input Offset Voltage	V_{OS}	$-55^\circ C \leq T_A \leq +125^\circ C$	—	1.0	—	2.0	mV
Input Offset Current	I_{OS}	$T_J = +25^\circ C$ $T_J = +125^\circ C$	—	50	—	50	pA
Input Bias Current	I_B	$T_J = +25^\circ C$ $T_J = +125^\circ C$	—	± 100	—	± 200	pA
Large-Signal Voltage Gain	A_{VO}	$V_O = \pm 10V, R_L \geq 2k\Omega$ $V_O = \pm 10V, R_L \geq 2k\Omega$ $-55^\circ C \leq T_A \leq +125^\circ C$	150	--	75	--	V/mV
Output Voltage Swing	V_O	$R_L \geq 2k\Omega$ $R_L \geq 10k\Omega$ $-55^\circ C \leq T_A \leq +125^\circ C$	± 11.0	—	± 11.0	—	V
Supply Current	I_{SY}	$V_O = 0V$	--	8.5	—	8.5	mA
Power Dissipation	P_d	$V_O = 0V$	--	255	—	255	mW
Slew Rate	SR	$A_{VCL} = +1$ $R_L \geq 2k\Omega, C_L = 100pF$	10.0	--	7.5	—	V/ μ s
Common-Mode Rejection	CMR	$V_{CM} = IVR = \pm 10.2V$ $V_{CM} = IVR = \pm 10.2V$ $-55^\circ C \leq T_A \leq +125^\circ C$	86	—	86	--	dB
Power Supply Rejection Ratio	PSRR	$V_S = \pm 10V \text{ to } \pm 16V$ $V_S = \pm 10V \text{ to } \pm 16V$ $-55^\circ C \leq T_A \leq +125^\circ C$	—	51	—	80	μ V/V
			—	100	—	100	μ V/V

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TABLE 1 (Continued)

$V_S = \pm 15V$; $R_S = 50\Omega$; $V_{CM} = 0V$; $T_A = 25^\circ C$ unless otherwise specified.

Characteristics	Symbol	Special Conditions	OP-215/883						Units		
			<u>LIMITS A</u>		<u>LIMITS B</u>		Min	Max	Min	Max	Units
Input Voltage Range (Note 1)	IVR	$-55^\circ C \leq T_A \leq +125^\circ C$	± 10.2	--	± 10.2	--	± 10.2	--	± 10.2	--	V
Gain Bandwidth Product	GBW	$f_O = 87.5\text{kHz}$	3.5	--	3.5	--	3.5	--	3.5	--	MHz

NOTES:

1. IVR is defined as the V_{CM} range used for the CMR test.

TABLE 1 (Continued)

$V_S = \pm 15V$; $R_S = 50\Omega$; $V_{CM} = 0V$; $T_A = 25^\circ C$ unless otherwise specified.

Characteristics	Symbol	Special Conditions	OP-215/883		Units
			Min	Max	
Input Offset Voltage	V_{OS}	$-55^\circ C \leq T_A \leq +125^\circ C$	--	4.0	mV
			--	6.0	mV
Input Offset Current	I_{OS}	$T_J = +25^\circ C$ $T_J = +125^\circ C$	--	100	pA
			--	12	nA
Input Bias Current	I_B	$T_J = +25^\circ C$ $T_J = +125^\circ C$	--	± 300	pA
			--	± 15	nA
Large-Signal Voltage Gain	A_{VO}	$V_O = \pm 10V$, $R_L \geq 2k\Omega$ $V_O = \pm 10V$, $R_L \geq 2k\Omega$ $-55^\circ C \leq T_A \leq +125^\circ C$	50	--	V/mV
			25	--	V/mV
Output Voltage Swing	V_O	$R_L \geq 2k\Omega$ $R_L \geq 10k\Omega$ $-55^\circ C \leq T_A \leq +125^\circ C$	± 11	--	V
			± 12	--	V
Supply Current	I_{SY}	$V_O = 0V$	--	10	mA
Power Dissipation	P_d	$V_O = 0V$	--	300	mW
Slew Rate	SR	$A_{VCL} = +1$ $R_L \geq 2k\Omega$, $C_L = 100pF$	5.0	--	V/ μ s
Common-Mode Rejection	CMR	$V_{CM} = IVR = \pm 10.1V$ $V_{CM} = IVR = \pm 10.1V$ $-55^\circ C \leq T_A \leq +125^\circ C$	82	--	dB
			80	--	dB
Power Supply Rejection Ratio	PSRR	$V_S = \pm 10V$ to $\pm 15V$ $V_S = \pm 10V$ to $\pm 15V$ $-55^\circ C \leq T_A \leq +125^\circ C$	--	100	μ V/V
			--	126	μ V/V

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TABLE 1 (Continued)

$V_S = \pm 15V$; $R_S = 50\Omega$; $V_{CM} = 0V$; $T_A = 25^\circ C$ unless otherwise specified.

Characteristics	Symbol	Special Conditions	<u>LIMITS C</u>		Units
			Min	Max	
Input Voltage Range (Note 1)	IVR		—	± 10.1	V
		$-55^\circ C \leq T_A \leq +125^\circ C$	—	± 10.1	V
Gain Bandwidth Product	GBW	$f_O = 75\text{kHz}$	3.0	—	MHz

NOTES:

1. IVR is defined as the V_{CM} range used for the CMR test.

TABLE 2

OP-215/883

**Electrical Test Requirements
For Class B Devices**

MIL-STD-883 Test Requirements	Subgroups (see Table 3)
Interim Electrical Parameters (pre Burn-In)	1
Final Electrical Test Parameters	1*, 2, 3, 4, 5, 6
Group A Test Requirements	1, 2, 3, 4, 5, 6, 7

* PDA applies to Subgroup 1 only.

No other Subgroups are included in PDA.

V_{OS} is excluded from PDA for OP-215A and OP-215B grade product.

TABLE 3

Group A Inspection

 $V_S = \pm 15V; R_S = 50\Omega; V_{CM} = 0V; T_A = T_J$ unless otherwise specified.

Subgroup	Symbol	Special Conditions	OP-215/883				Units
			Min	Max	Min	Max	
Subgroup 1 $T_A = +25^\circ C$	V_{OS}		—	1.0	—	2.0	mV
	I_{OS}		—	50	—	50	pA
	I_B		—	± 100	—	± 200	pA
	I_{SY}		—	8.5	—	8.5	mA
	CMR	$V_{CM} = \pm 10.2V$	86	—	86	—	dB
	PSRR	$V_S = \pm 10V, \pm 16V$	—	51	—	80	$\mu V/V$
Subgroup 2 $T_A = +125^\circ C$	V_{OS}		—	2.0	—	3.0	mV
	I_{OS}		—	8	—	8	nA
	I_B		—	± 10	—	± 10	nA
	CMR	$V_{CM} = \pm 10.2V$	82	—	82	—	dB
	PSRR	$V_S = \pm 10V, \pm 16V$	—	100	—	100	$\mu V/V$
	V_{OS}		—	2.0	—	3.0	mV
Subgroup 3 $T_A = -55^\circ C$	CMR	$V_{CM} = \pm 10.2$	82	—	82	—	dB
	PSRR	$V_S = \pm 10V, \pm 16V$	—	100	—	100	$\mu V/V$
Subgroup 4	V_O	$R_L = 2k\Omega$	± 11	—	± 11	—	V
$T_A = +25^\circ C$	A_{VO}	$V_O = \pm 10V, R_L = 2k\Omega$	150	—	75	—	V/mV
Subgroup 5	V_O	$R_L = 10k\Omega$	± 12	—	± 12	—	V
$T_A = +125^\circ C$	A_{VO}	$V_O = \pm 10V, R_L = 2k\Omega$	30	—	30	—	V/mV



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TABLE 3

Group A Inspection (Continued)

$V_S = \pm 15V$; $R_S = 50\Omega$; $V_{CM} = 0V$; $T_A = T_J$ unless otherwise specified.

Subgroup	Symbol	Special Conditions	OP-215/883		LIMITS A		LIMITS B		Units
			Min	Max	Min	Max	Min	Max	
Subgroup 6 $T_A = -55^\circ C$		All Tests, Limits and Conditions are the same as for Subgroup 5.							
Subgroup 7 $T_A = +25^\circ C$	SR	$A_{VCL} = +1$ $R_L = 2k\Omega$, $C_L = 100pF$	10.0	-	7.5	-	V/ μ s		
	GBW	$f_O = 87.5kHz$	3.5	--	3.5	--	MHz		

TABLE 3

Group A Inspection (Continued)

 $V_S = \pm 15V$; $R_S = 50\Omega$; $V_{CM} = 0V$; $T_A = T_J$ unless otherwise specified.

Subgroup	Symbol	Special Conditions	OP-215/883		Units
			Min	Max	
Subgroup 1 $T_A = +25^\circ C$	V_{OS}		—	4.0	mV
	I_{OS}		—	100	pA
	I_B		—	± 300	pA
	I_{SY}	$V_O = 0V$	—	10	mA
	CMR	$V_{CM} = \pm 10.1V$	82	—	dB
Subgroup 2 $T_A = +125^\circ C$	V_{OS}		--	6.0	mV
	I_{OS}		—	12	nA
	I_B		—	± 15	nA
	CMR	$V_{CM} = \pm 10.1V$	80	—	dB
	PSRR	$V_S = \pm 10V, \pm 15V$	—	126	$\mu V/V$
Subgroup 3 $T_A = -55^\circ C$	V_{OS}		--	6.0	mV
	CMR	$V_{CM} = \pm 10.1V$	80	—	dB
	PSRR	$V_S = \pm 10V, \pm 15V$	—	126	$\mu V/V$
Subgroup 4 $T_A = +25^\circ C$	V_O	$R_L = 2k\Omega$	± 11	—	V
	A_{VO}	$V_O = \pm 10V, R_L = 2k\Omega$	50	—	V/mV
Subgroup 5 $T_A = +125^\circ C$	V_O	$R_L = 10k\Omega$	± 12	—	V
	A_{VO}	$V_O = \pm 10V, R_L = 2k\Omega$	25	—	V/mV

TABLE 3

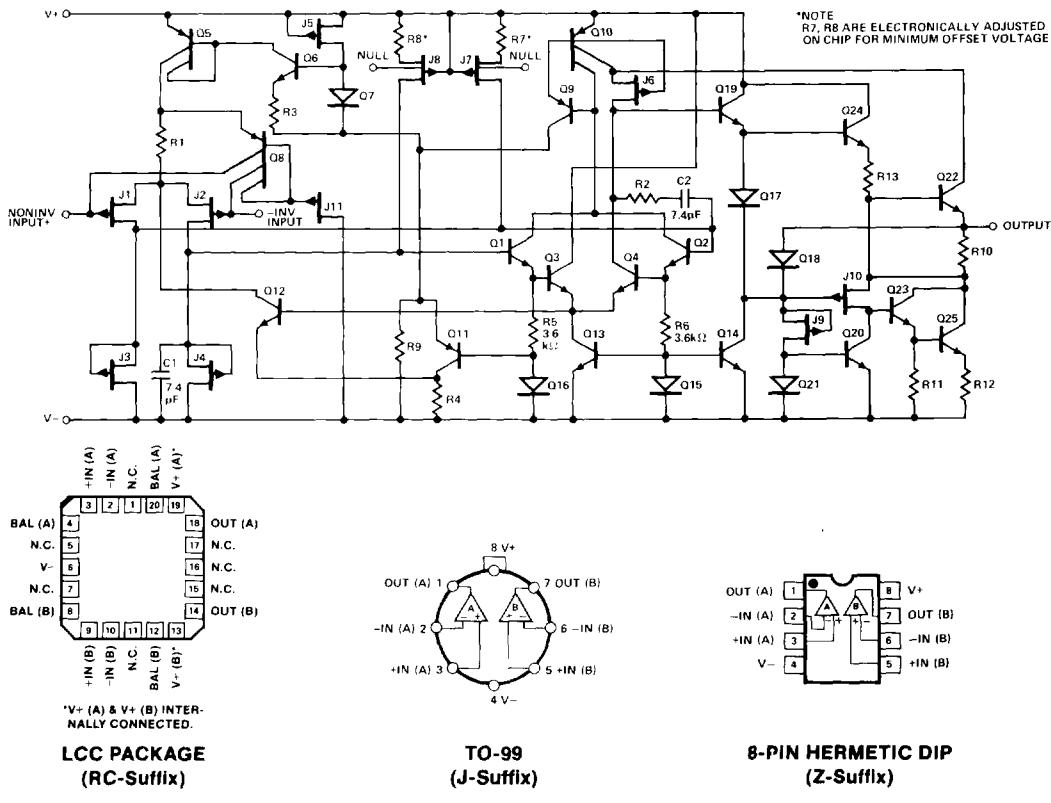
Group A Inspection (Continued)

$V_S = \pm 15V$; $R_S = 50\Omega$; $V_{CM} = 0V$; $T_A = T_J$ unless otherwise specified.

Subgroup	Symbol	Special Conditions	<u>LIMITS C</u>		Units
			Min	Max	
Subgroup 6 $T_A = -55^\circ C$		All Tests, Limits and Conditions are the same as for Subgroup 5.			
Subgroup 7 $T_A = +25^\circ C$	SR	$A_{VCL} = +1$ $R_L = 2k\Omega$, $CL = 100pF$	5.0	-	$V/\mu s$
	GBW	$f_O = 75kHz$	3.0	-	MHz

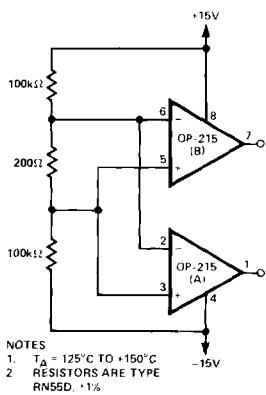
3.2.1 Simplified Schematic and Pin Connections.

(1/2 OP-215)

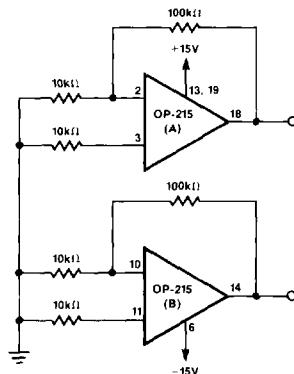


3.2.4 Microcircuit Group Assignment. This microcircuit is covered by microcircuit group 49.

4.2 Life Test/Burn-In Circuit.



("J" AND "Z" PACKAGES ONLY)



("RC" PACKAGE)